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## STGD6NC60H-1

# N-channel 600 V, 7 A - IPAK Very fast PowerMESH™ IGBT

Datasheet - production data

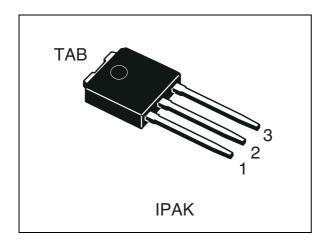
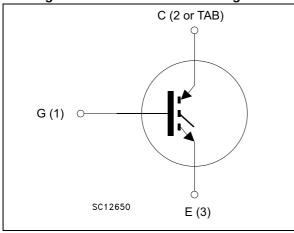


Figure 1. Internal schematic diagram



### **Features**

Туре	V <sub>CES</sub>	V <sub>CE(sat)</sub> max@25°C	l <sub>C</sub> @100°C
STGD6NC60H	600V	<2.5V	7A

- Low on voltage drop (V<sub>cesat</sub>)
- Low C<sub>RES</sub> / C<sub>IES</sub> ratio (no cross-conduction susceptibility)
- High frequency operation

### **Description**

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH $^{\text{TM}}$  IGBTs, with outstanding performances. The suffix H identifies a family optimized for high frequency application in order to achieve very high switching performances (reduced  $t_{\text{fall}}$ ) maintaining a low voltage drop.

## **Applications**

- High frequency inverters
- SMPS and PFC in both hard switch and resonant topologies
- Motor drivers

Table 1. Device summary

Part number	Marking	Package	Packaging
STGD6NC60H-1	GD6NC60H	IPAK	Tube

Contents STGD6NC60H-1

# **Contents**

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STGD6NC60H-1 Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage (V <sub>GS</sub> = 0)	600	V
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at T <sub>C</sub> = 25°C	15	Α
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at T <sub>C</sub> = 100°C	7	Α
I <sub>CM</sub> <sup>(2)</sup>	Collector current (pulsed)	21	Α
V <sub>GE</sub>	Gate-emitter voltage	±20	V
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25°C	62.5	W
T <sub>stg</sub>	Storage temperature	– 55 to 150	°C
T <sub>j</sub>	Operating junction temperature	- 55 (0 150	
T <sub>I</sub>	Maximum lead temperature for soldering purpose (for 10sec. 1.6 mm from case)	300	°C

<sup>1.</sup> Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{JMAX} - T_{C}}{R_{THJ} - C^{\times V}CESAT(MAX)(T_{C}, I_{C})}$$

2. Pulse width limited by max junction temperature

**Table 3. Thermal resistance** 

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	2	°C/W
Rthj-amb	Thermal resistance junction-ambient max	100	°C/W

Electrical characteristics STGD6NC60H-1

# 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>BR(CES)</sub>	Collector-emitter breakdown voltage	I <sub>C</sub> = 1mA, V <sub>GE</sub> = 0	600			V
V-=	Collector-emitter saturation	V <sub>GE</sub> = 15V, I <sub>C</sub> = 3A		1.9	2.5	٧
V <sub>CE(sat)</sub>	voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 3A, Tc= 125°C		1.7		٧
V <sub>GE(th)</sub>	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_{C} = 250 \mu A$	3.75		5.75	٧
1	Collector cut-off current	V <sub>CE</sub> = 600V			10	μΑ
I <sub>CES</sub>	$(V_{GE} = 0)$	V <sub>CE</sub> = 600V, T <sub>C</sub> = 125°C			1	mA
I <sub>GES</sub>	Gate-emitter leakage current (V <sub>CE</sub> = 0)	V <sub>GE</sub> = ±20V, V <sub>CE</sub> = 0			±100	nA
9 <sub>fs</sub>	Forward transconductance	$V_{CE} = 15V_{,} I_{C} = 3A$		3		S

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>ies</sub>	Input capacitance		-	205	-	pF
C <sub>oes</sub>	Output capacitance	$V_{CE} = 25V$ , $f = 1MHz$ , $V_{GE} = 0$	-	32	-	pF
C <sub>res</sub>	Reverse transfer capacitance		-	5.5	-	pF
Qg	Total gate charge	$V_{CE} = 390V, I_{C} = 3A,$	-	13.6	-	nC
Q <sub>ge</sub>	Gate-emitter charge	V <sub>GE</sub> = 15V, (see Figure 17)		3.4		nC
Q <sub>gc</sub>	Gate-collector charge			5.1		nC
I <sub>CL</sub>	Turn-off SOA minimum current	$V_{clamp}$ =390V, Tj=150°C, $R_G$ =15V	-	19	-	Α

Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{CC} = 390V, I_{C} = 3A$	-	12	-	ns
t <sub>r</sub>	Current rise time	$R_{G}$ = 10 $\Omega$ , $V_{GE}$ = 15 $V$ ,	-	5	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	(see Figure 18)	-	612	-	A/μs
t <sub>d(on)</sub>	Turn-on delay time	$V_{CC} = 390V, I_{C} = 3A$ $R_{G} = 10\Omega, V_{GE} = 15V,$ $T_{J} = 125^{\circ}C$	-	13	-	ns
t <sub>r</sub>	Current rise time		-	4.3	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	(see Figure 18)		560	-	Aμs
t <sub>r(Voff)</sub>	Off voltage rise time	V <sub>CC</sub> = 390V, I <sub>C</sub> = 3A,	-	40	-	ns
t <sub>d(off)</sub>	Turn-off delay time	$R_{GE} = 10\Omega$ , $V_{GE} = 15V$ (see Figure 18)	-	76	-	ns
t <sub>f</sub>	Current fall time		-	100	-	ns
t <sub>r(Voff)</sub>	Off voltage rise time	$V_{CC} = 390V, I_{C} = 3A,$ $R_{GE} = 10\Omega, V_{GE} = 15V,$ $T_{J} = 125^{\circ}C$	-	60	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	98	-	ns
t <sub>f</sub>	Current fall time	(see Figure 18)	-	124	-	ns

Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
E <sub>on</sub> <sup>(1)</sup>	Turn-on switching losses	$V_{CC} = 390V, I_{C} = 3A$	-	20	-	μJ
E <sub>off</sub> <sup>(2)</sup>	Turn-off switching losses	$R_G = 10\Omega$ , $V_{GE} = 15V$	-	68	-	μJ
E <sub>ts</sub>	Total switching losses	(see Figure 18)	-	88	-	μJ
E <sub>on</sub> <sup>(1)</sup>	Turn-on switching losses	V <sub>CC</sub> = 390V, I <sub>C</sub> = 3A	-	37	-	μJ
E <sub>off</sub> <sup>(2)</sup>	Turn-off switching losses	R <sub>G</sub> = 10Ω, V <sub>GE</sub> =15V, Tj=	-	93	-	μJ
E <sub>ts</sub>	Total switching losses	(see Figure 18)	1	130	-	μJ

Eon is the tun-on losses when a typical diode is used in the test circuit in Figure 18. If the IGBT is offered
in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the
same temperature (25°C and 125°C)



<sup>2.</sup> Turn-off losses include also the tail of the collector current

Electrical characteristics STGD6NC60H-1

## 2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

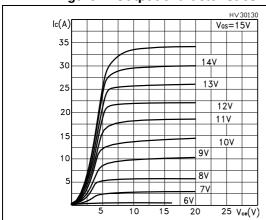


Figure 3. Transfer characteristics

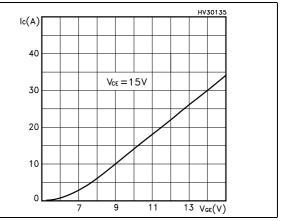
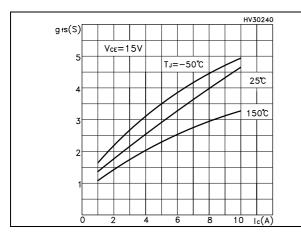


Figure 4. Transconductance

Figure 5. Collector-emitter on voltage vs temperature



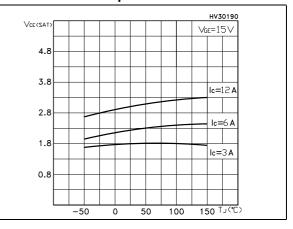


Figure 6. Gate charge vs gate-source voltage

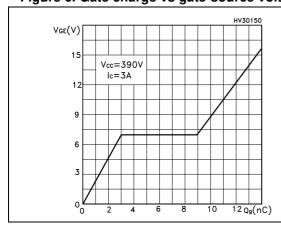
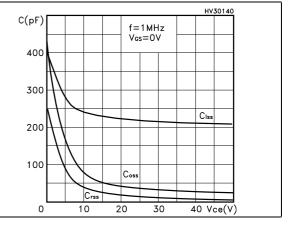


Figure 7. Capacitance variations

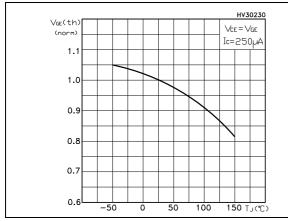


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Figure 8. Normalized gate threshold voltage vs temperature

Figure 9. Collector-emitter on voltage vs collector current



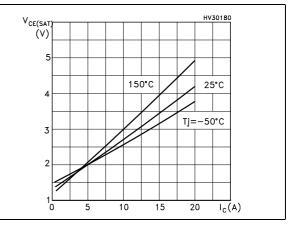
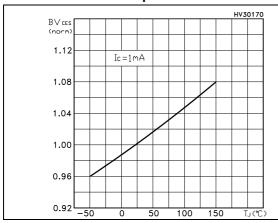


Figure 10. Normalized breakdown voltage vs temperature

Figure 11. Switching losses vs temperature



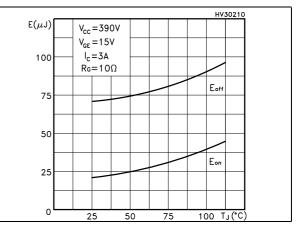
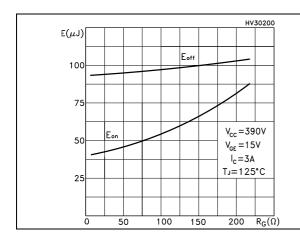
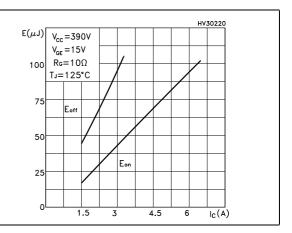


Figure 12. Switching losses vs gate resistance Figure 13. Switching losses vs collector current

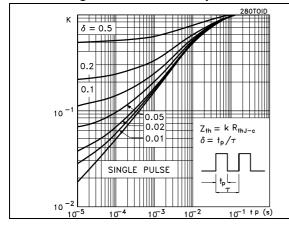


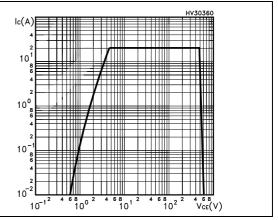


Electrical characteristics STGD6NC60H-1

Figure 14. Thermal impedance

Figure 15. Turn-off SOA





STGD6NC60H-1 Test circuit

## 3 Test circuit

Figure 16. Test circuit for inductive load switching

Figure 17. Gate charge test circuit

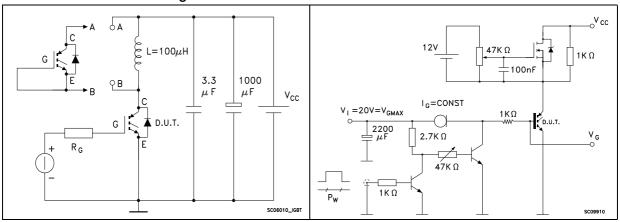
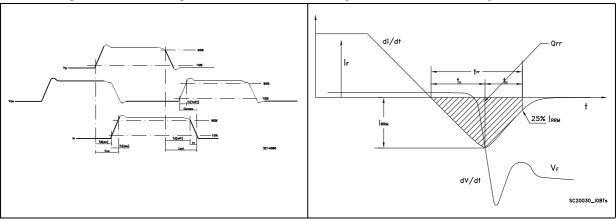


Figure 18. Switching waveform

Figure 19. Diode recovery time waveform



#### Package mechanical data 4

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Figure 20. IPAK (TO-251) drawing L2 D b2 (3x) b (3x) *B5* e 1 0068771\_K

Table 8. IPAK (TO-251) mechanical data

DIM		mm.	max. 2.40 1.10 0.90 0.95 5.40  0.60 0.60 6.20 6.60  4.60
DIM	min.	typ.	max.
А	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
B5		0.30	
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
е		2.28	
e1	4.40		4.60
Н		16.10	
L	9.00		9.40
L1	0.80		1.20
L2		0.80	1.00
V1		10°	



Revision history STGD6NC60H-1

# 5 Revision history

Table 9. Revision history

Date	Revision	Changes
08-Apr-2014	1	First release.

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